JJMICROELECTRONICS

40V, 297A, 1.2mΩ N-channel Power SGT MOSFET JMSL0401PG

Features

- Excellent $R_{\text{DS}(\text{ON})}$ and Low Gate Charge
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant

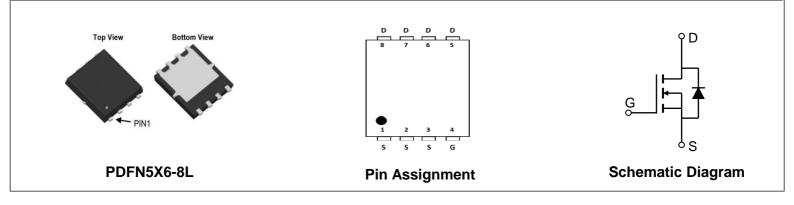
Applications

- Load Switch
- PWM Application
- Power Management

Product Summary

Parameters	Value	Unit
V _{DSS}	40	V
V _{GS(th)_Typ}	1.8	V
I _D (@V _{GS} =10V)	297	А
R _{DS(ON)_Typ} (@V _{GS} =10V	0.8	mΩ
R _{DS(ON)_Typ} (@V _{GS} =4.5V	1.2	mΩ





Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSL0401PG-13	SL0401P	1	Tape&Reel	PDFN5x6-8L	5000	50000

Absolute Maximum Ratings (@ $T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter		Value	Unit
V _{DS}	Drain-to-Source Voltage		40	V
V_{GS}	Gate-to-Source Voltage		±20	V
1-	Continuous Drain Current	$T_C = 25^{\circ}C$	297	А
Ι _D	Continuous Drain Current	$T_{\rm C} = 100^{\circ}{\rm C}$	188	A
I _{DM}	Pulsed Drain Current ⁽¹⁾		Refer to Fig.4	А
E _{AS}	Single Pulsed Avalanche Energy ⁽²⁾		706	mJ
P _D	Power Dissipation	T _C = 25°C	156	w
' D		$T_{\rm C} = 100^{\circ}{\rm C}$	63	VV
T _J , T _{STG}	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Мах	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.8	0/00

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	l aracteristics					<u> </u>
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0V$	40	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32V, V_{GS} = 0V$	-	-	1.0	μA
I_{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2	1.8	2.3	V
		$V_{GS} = 10V, I_D = 20A$	-	0.8	1.1	mΩ
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 4.5V, I_{D} = 15A$	-	1.2	1.7	mΩ
Dynami	ic Characteristics					
R_g	Gate Resistance	f = 1MHz	-	0.9	-	Ω
C_{iss}	Input Capacitance		4720	6608	8920	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	1995	2793	3770	pF
C _{rss}	Reverse Transfer Capacitance		167	234	316	pF
Qg	Total Gate Charge		77	108	146	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_D = 20A$	14	19	26	nC
Q_gd	Gate Drain("Miller") Charge	VDS - 20V, ID - 20V	16	22	29	nC
	ing Characteristics					
t _{d(on)}	Turn-On DelayTime	4	-	17	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 20V$	-	33	-	ns
t _{d(off)}	Turn-Off DelayTime	$I_D = 20A, R_{GEN} = 3\Omega$	-	68	-	ns
t _f	Turn-Off Fall Time		-	26	-	ns
	iode Characteristics	-		1		
ا _S	Maximum Continuous Body Diode Forward Current		-	-	297	A
I _{SM}	Maximum Pulsed Body Diode Forward Curr		-	-	1188	A
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	I _F = 20A, di/dt = 100A/us	45	63	85	ns
Qrr	Body Diode Reverse Recovery Charge		-	93	-	nC

Electrical Characteristics ($T_J = 25^{\circ}C$ unless otherwise specified)

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

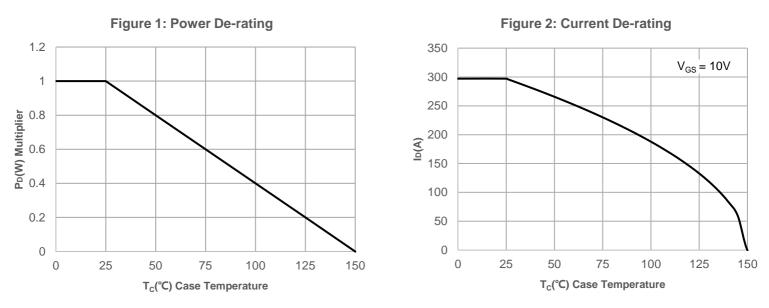
2. E_{AS} condition: Starting T_J =25C, V_{DD} =20V, V_{GS} =10V, R_G =25ohm, L=3mH, I_{AS} =21.7A, V_{DD} =0V during time in avalanche.

3. $R_{\theta JA}$ is measured with the device mounted on a 1inch^2 pad of 2oz copper FR4 PCB.

4. Pulse Test: Pulse Width ${\leqslant}300\mu\text{s},$ Duty Cycle ${\leqslant}0.5\%.$

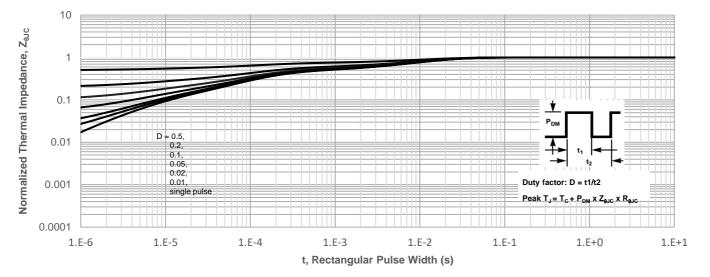




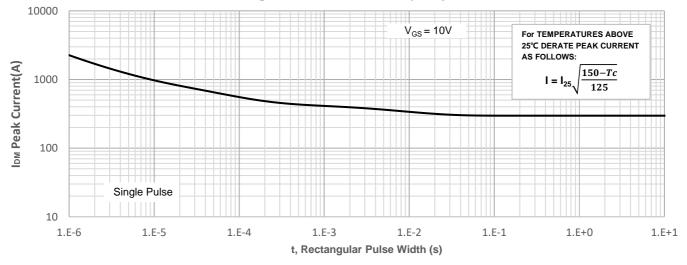


Typical Performance Characteristics









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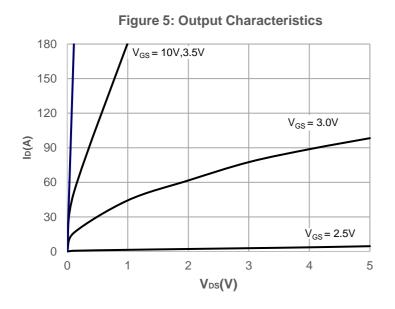


Figure 6: Typical Transfer Characteristics 20 $V_{DS} = 5V$ 16 12 ID(A) $T_J = 125^{\circ}C$ T_J = -55°C 8 $T_J = 25^{\circ}C$ 4 0 2 3 4 5 1 Vgs(V)

Figure 8: Body Diode Characteristics

100

10

1

0.1

0.01

0

Is(A)

 $V_{GS} = 0V$

T_J = 125°C

0.2

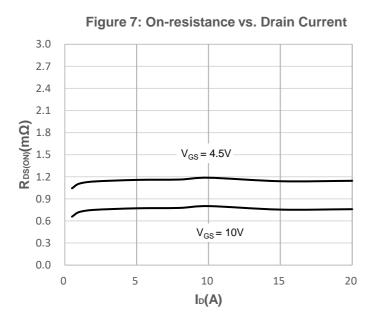


Figure 9: Gate Charge Characteristics

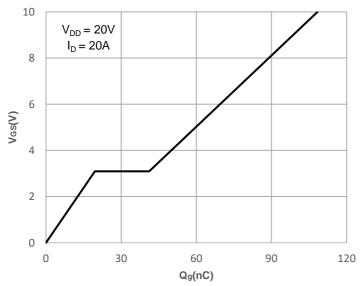


Figure 10: Capacitance Characteristics

0.8

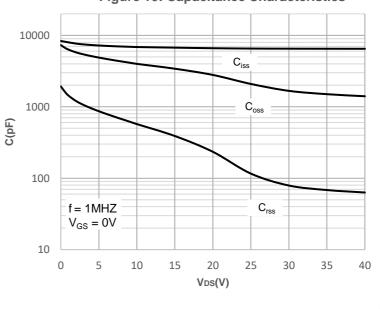
0.6

Vsd(V)

 $T_J = -55^{\circ}C$

1

1.2



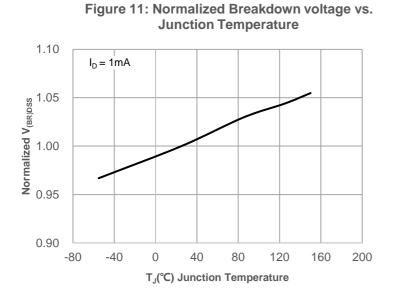
= 25°C

0.4

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Typical Performance Characteristics





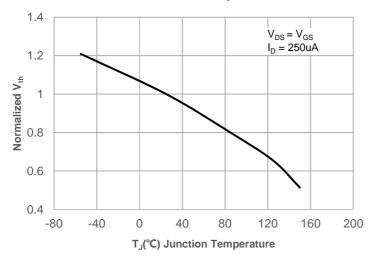
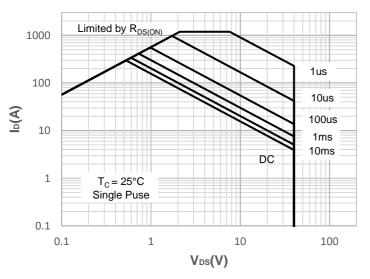
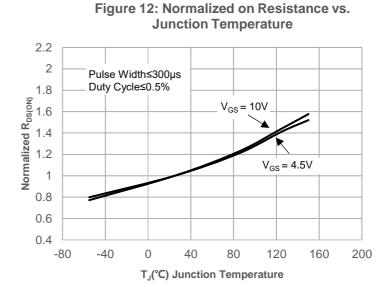
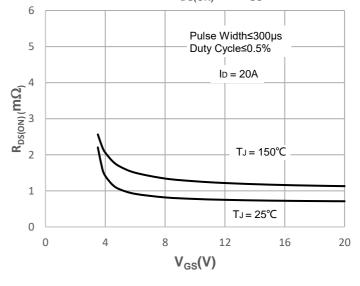


Figure 15: Maximum Safe Operating Area











Test Circuit

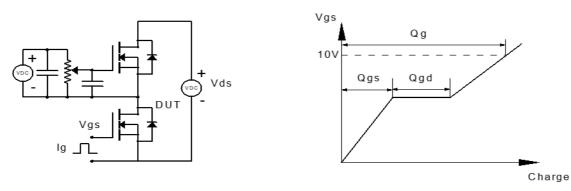


Figure 1: Gate Charge Test Circuit & Waveform

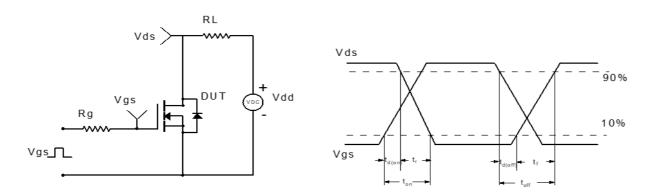


Figure 2: Resistive Switching Test Circuit & Waveform

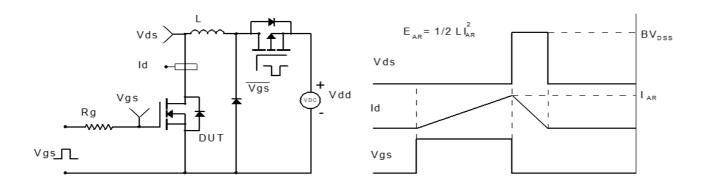


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

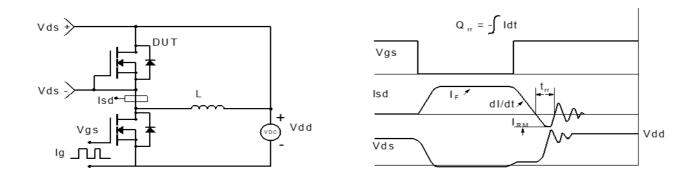


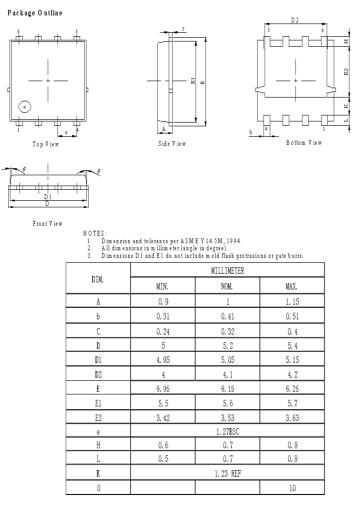
Figure 4: Diode Recovery Test Circuit & Waveform

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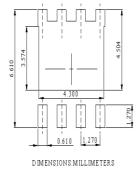
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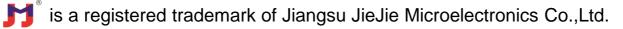
Package Mechanical Data(PDFN5x6-8L)



Recommended Soldering Footprint



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